



Ref. Certif. No.

DE 3 - 32831

IEC SYSTEM FOR MUTUAL RECOGNITION OF TEST CERTIFICATES FOR ELECTRICAL EQUIPMENT (IECEE) CB SCHEME

## CB TEST CERTIFICATE

Product	Laboratory Equipment (Microscopes)
Name and address of the applicant	<b>Leica Microsystems (Schweiz) AG</b> Max Schmidheiny-Str. 201 9435 Heerbrugg SWITZERLAND
Name and address of the manufacturer	Leica Microsystems (Schweiz) AG Max Schmidheiny-Str. 201, 9435 Heerbrugg, SWITZERLAND
Name and address of the factory	Zhangjiagang Optical Instrument Co., Ltd Nanlin Development Zone, 215616 Zhangjiagang City, PEOPLE'S REPUBLIC OF CHINA
Ratings and principal characteristics	Voltage: 100–240 VAC Frequency: 50/60 Hz Wattage: max. 17 W
Trademark / Brand (if any)	Leica
Model/type Ref.	DM500 (X) DM750 (X), DM750 M (X), DM750 P (X) (X) optional, where (X) can be one or more alphanumeric digits to reflect customer specific version and represent optical accessories and/or different sample holder, not relevant for safety.
Additional information (if necessary)	Certificate DE 3 – 32097 issued 2023-06-30 is replaced by this version due to technical changes. Evaluated to National and Group Differences for US, CA, EU.
A sample of the product was tested and found to be in conformity with	IEC 61010-1:2010 IEC 61010-1:2010/AMD1:2016
as shown in the Test Report Ref. No. which forms part of this certificate	713304202, Rev.01

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This CB Test Certificate is issued by the National Certification Body

CB 042849 0005 Rev. 01

Date, 2026-05-18

( Martin Heinrich )

TÜV SÜD Product Service GmbH • Certification Body • Ridlerstraße 65 • 80339 Munich • Germany

